

Notice of References Cited	Application/Control No. 10/630,714	Applicant(s)/Patent Under Reexamination YOSHIDA, KEISUKE	
	Examiner Pierre-Michel Bataille	Art Unit 2186	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,738,966	05-2004	Tanaka, Akira	717/140
*	B	US-2003/0233385	12-2003	Srinivasa et al.	709/1
	C	US-			
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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